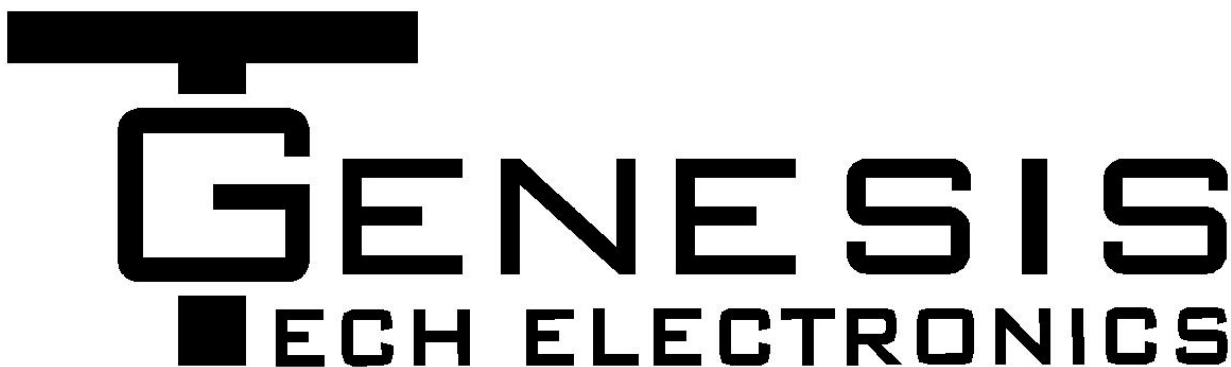


GENESIS TECH ELECTRONICS INC.

PRODUCT SPECIFICATION: 110-10008

GENESIS PN: 110-10008-01



SPECIFICATION FOR APPROVAL

CUSTOMER:

CUSTOMER PART NO:

PART NO: 110-10008-01

REVISION: X1

DESCRIPTION: HIGH SPEED B TO B 5 Gbps FEMALE INTERFACE

	MANUFACTURE SIGNATURE	CUSTOMER SIGNATURE
APPROVED BY:		
DATE:		

GENESIS TECH ELECTRONICS INC.

7F-1, No. 191, Sec. 2, Chung-Yang Rd.,

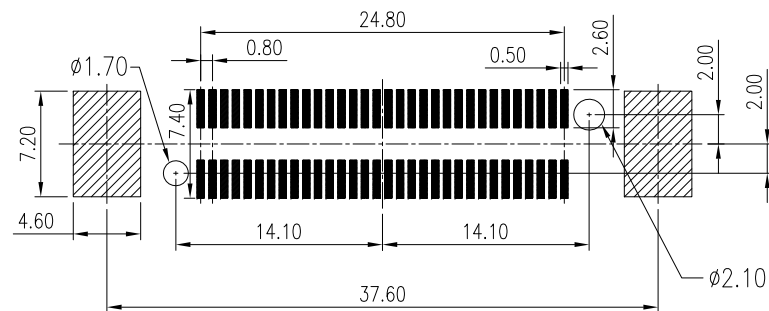
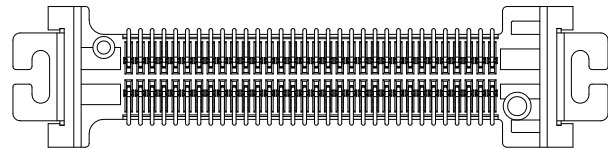
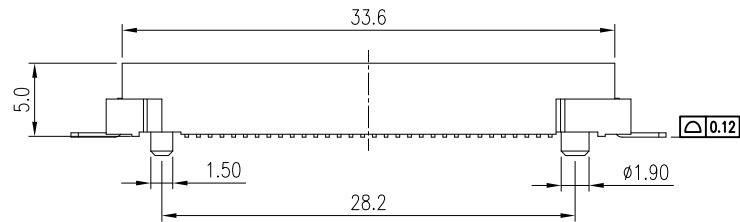
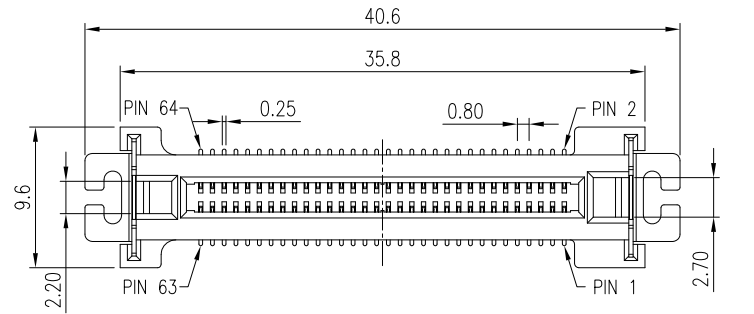
Tu-Cheng City, Taipei Hsien, Taiwan

TEL: +886-2-2262-0027

FAX: +886-2-2274-7954

PROPRIETARY INFORMATION
COMPANY CONFIDENTIAL

REV.	ECN. NO.	DESCRIPTION	ENG	DATE
X1		INITIAL	AXL	2/17/2016



RECOMMENDED PCB LAYOUT
TOLERANCE: ±0.05mm

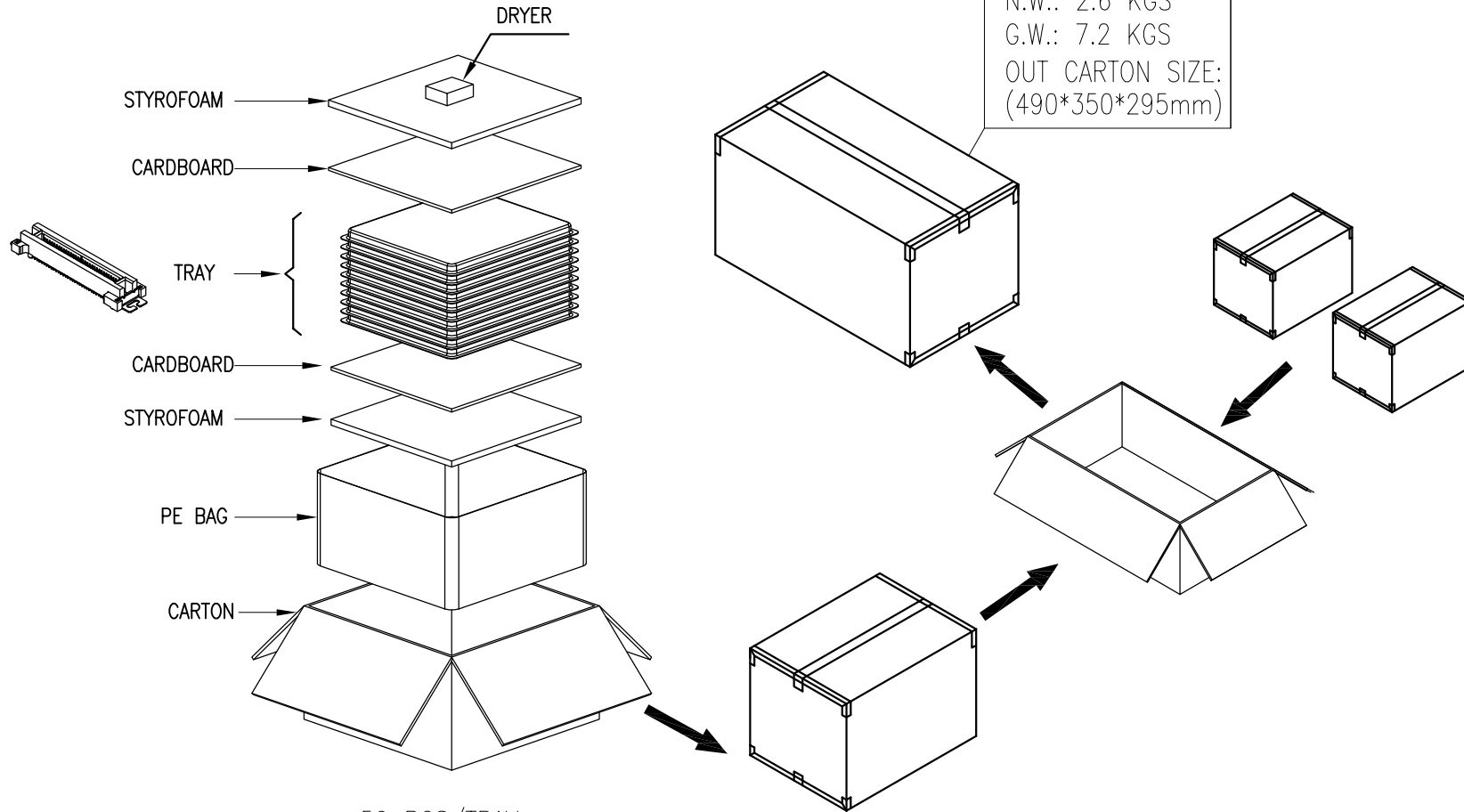
NOTES :

- MATERIAL
HOUSING: LCP, UL94V-0, BLACK
TERMINAL: PHOSPHOR BRONZE
BOARDLOCK: BRASS
- PLATING:
TERMINAL:
CONTACT AREA: GOLD FLASH PLATING
SOLDER TAIL: 80u" TIN PLATING
UNDER PLATING: 30u" NICKEL OVERALL
BOARDLOCK: 30u" NICKEL PLATING
- CURRENT RATING: 0.5A
- DIELECTRIC WITHSTANDING VOLTAGE: 500VAC FOR 1 MINUTE.
- INSULATION RESISTANCE: 100Mohms min.
- 5Gbps min. COMPLIANT.
- DESIGN TO MATE WITH 110-10007.
- TRAY PACKAGING.

GENERAL TOLERANCE X.± 0.50 .X± 0.40 .XX± 0.30 .XXX± 0.20	ANGLE TOLERANCE X°± 5.0° .X°± 3.0° .XX°± 2.0° .XXX°± 1.0°	DRAWN AXL	DATE 2/17/16'	 TITLE: HIGH SPEED B TO B 5Gbps FEMALE INTERFACE PART NUMBER: 110-10008-01
MATL SEE BOM	FINISH SEE NOTES	CHECKED	DATE	
SCALE N/A	UNIT mm	APPROVED	DATE	DRAWING NO. 110-10008
SHEET 1 OF 1				SIZE A4 REV. X1

PROPRIETARY INFORMATION
COMPANY CONFIDENTIAL

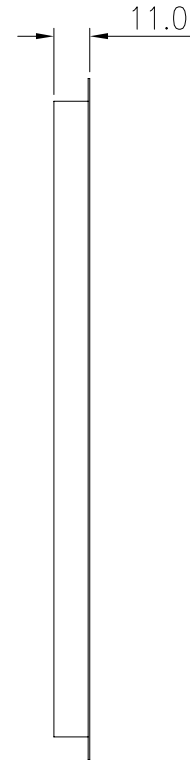
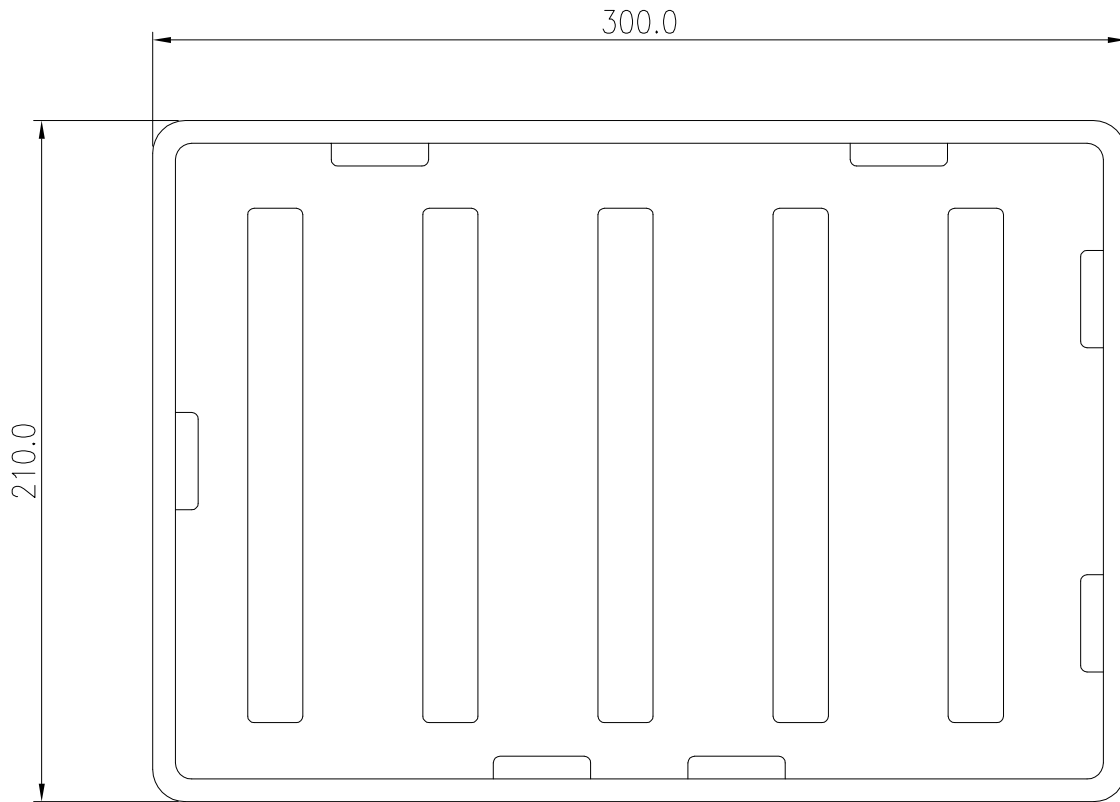
REV.	ECN. NO.	DESCRIPTION	ENG	DATE
X1		INITIAL	Jane	08/23/16



50 PCS/TRAY
20 TRAY/CARTON

GENERAL TOLERANCE X.± .X± .XX± .XXX±	ANGLE TOLERANCE X°± .X°± .XX°± .XXX°±	DRAWN Jane	DATE 08/23/16	 TITLE: HIGH SPEED B TO B FEMALE CONNECTOR PART NUMBER: 110-10008 PACKING DRAWING NO. 110-10008 SIZE A4 REV. X1
MATL SEE BOM	FINISH SEE NOTES	CHECKED	DATE	
SCALE N/A	UNIT mm	APPROVED	DATE	
SHEET 1 OF 1				

PROPRIETARY INFORMATION
COMPANY CONFIDENTIAL

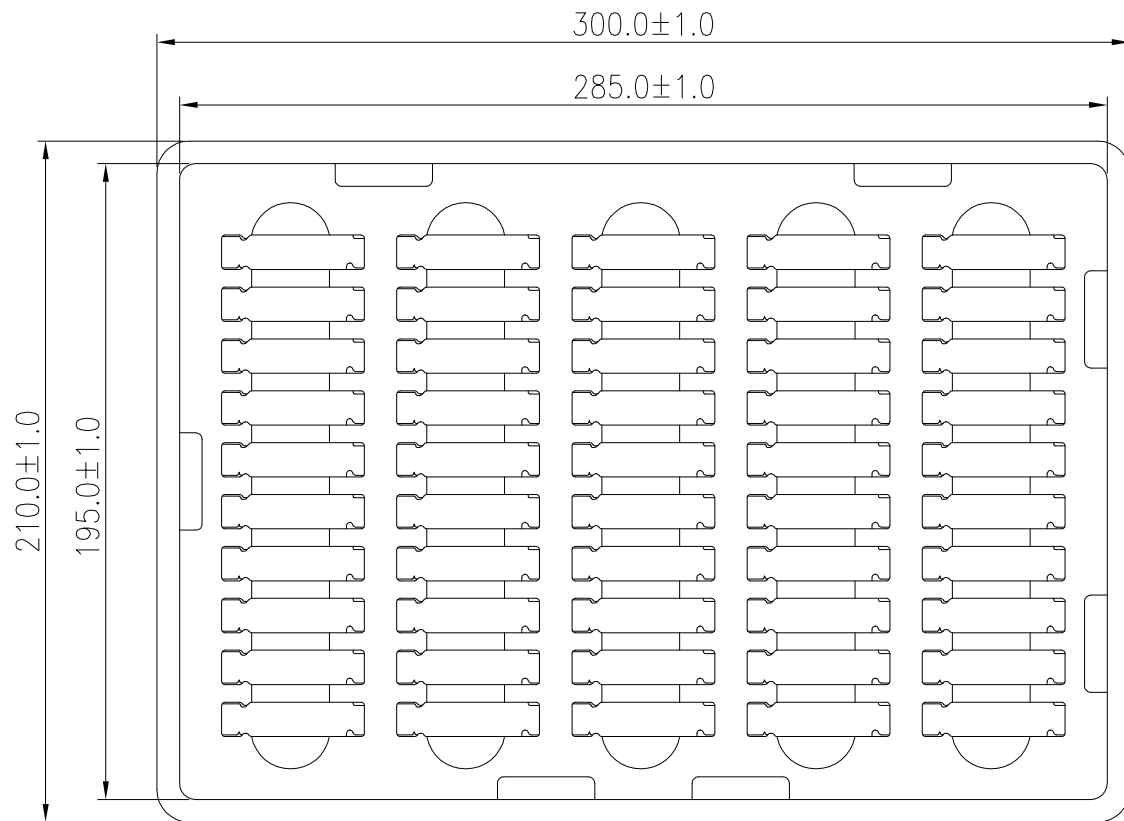


注:

1. 未标注公差均为: $\pm 2\text{mm}$.
2. 尺寸 >100 公差为: $\pm 5.0\text{mm}$.
3. 材质: PET.
4. 未注拔模斜度: $5^\circ \pm 2^\circ$.
5. 進料檢驗時需拿產品實際試配.

GENERAL TOLERANCE X.± .X± .XX± .XXX±	ANGLE TOLERANCE X°± .X°± .XX°± .XXX°±	DRAWN	DATE		
		Jane	05/13/16'		
MATL SEE BOM		CHECKED	DATE	TITLE. PACKING DWG	
FINISH SEE NOTES		APPROVED		PART NUMBER. 110-10008 上蓋	
SCALE N/A	UNIT mm	DATE		DRAWING NO.	SIZE A4
SHEET 1 OF 1				REV. A	

PROPRIETARY INFORMATION
COMPANY CONFIDENTIAL



注:

1. 公差均为: $\pm 2\text{mm}$.
2. 材质: PS
3. 未注拔模斜度: $5^\circ \pm 2^\circ$.
4. 进料检验时需拿产品实际试配.

GENERAL TOLERANCE X.± .X± .XX± .XXX±	ANGLE TOLERANCE X°± .X°± .XX°± .XXX°±	DRAWN Jane	DATE 12/23/16'	
MATL SEE BOM		CHECKED	DATE	
FINISH SEE NOTES		APPROVED		DATE
SCALE N/A	UNIT mm	SHEET 1 OF 1		DRAWING NO. 110-10008 底蓋
				SIZE A4 REV. C

GENESIS TECH ELECTRONICS INC.

PRODUCT SPECIFICATION: 110-10008
GENESIS PN: 110-10008-01

1 SCOPE

This specification covers the performance requirements of the High Speed 5Gbps Female Interface.

2 APPLICATION DOCUMENT

This following documents form a part of this specification to this extent specified herein. In the event of conflict between the requirements of the specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

- EIA-364
- UL-94

3 REQUIREMENTS

3.1 DESIGN AND CONSTRUCTION

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing 110-10008 and Mates with 110-10007-01.

3.2 MATERIAL

- A. Housing : LCP+Glass Filled, UL94V-0,Black.
- B. Terminal : Phosphor bronze , gold plated on contact area, Tin plated on solder tails, nickel Underplated over all
- C. Board lock : Brass, Tin plated on solder tails, nickel Underplated over all

3.3 RATINGS

- A. Current rating : 0.5 Amperes
- B. Voltage rating : 30V DC Max.
- C. Operating temperature : -30°C to 85°C .
- D. Humidity : 20% - 80%

3.4 STORAGE CONDITIONS

Temperature : $25 \pm 5^{\circ}\text{C}$; Humidity : 50% - 70%
Storage time : Should not exceed 90 days.

3.5 CONDITION OF WAVE SOLDERING AND BY HAND

Hand solder: 350±10°C, 3±1 sec.
 Reflow: Max 260°C 5 sec, 230°C 60 sec (pre-heat at 130~180°C,60~120 sec) 2 times
 Tested to profile shown below. Recommended to use fixture for soldering stability.

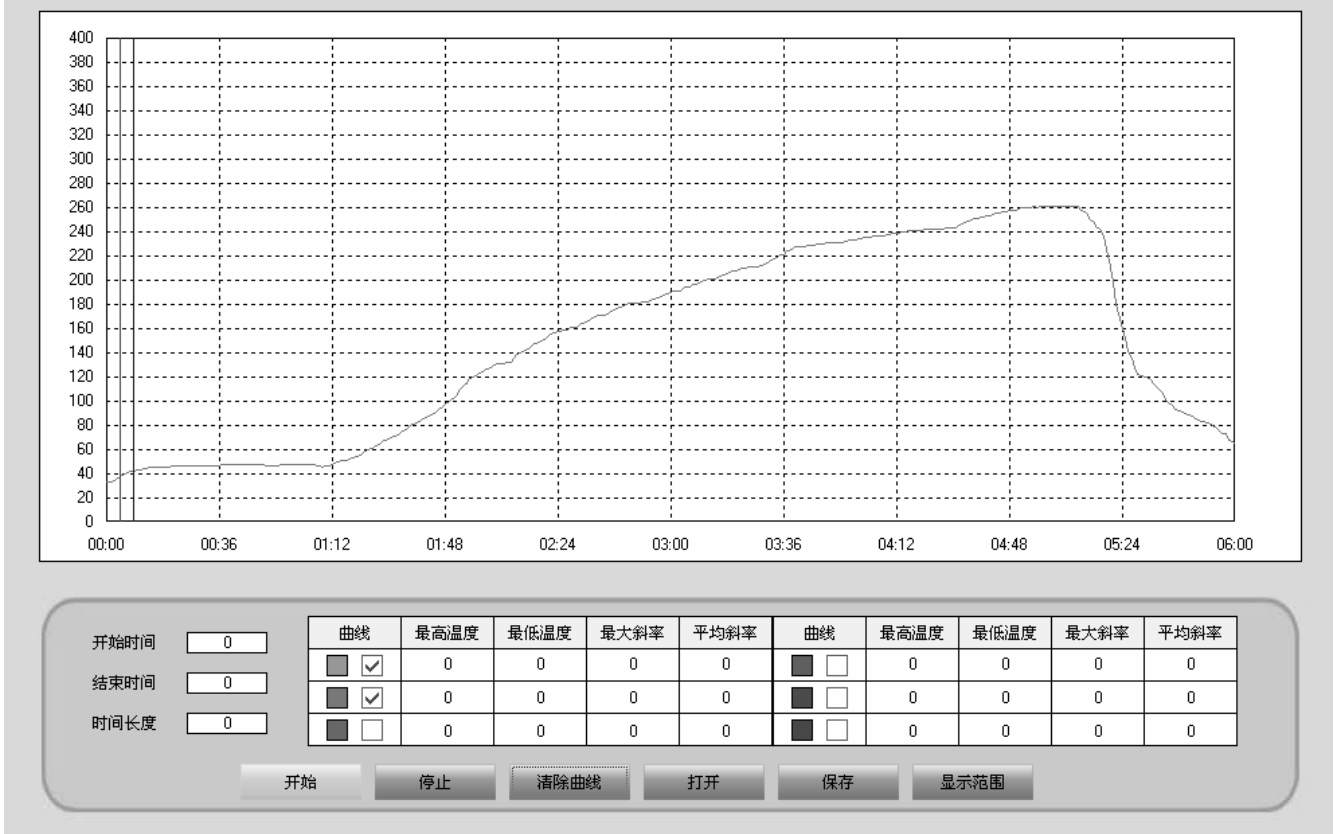


Figure 1 – Solder Reflow Profile Tested

3.6 TEST CONDITIONS

The product is designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 2.

3.7 ELECTRICAL PERFORMANCE

Parameter	Procedure	Requirement
Insulation resistance	EIA 364-21 Test between adjacent contacts of mated and unmated connector assemblies.	100 MΩ minimum
Dielectric withstanding voltage	EIA 364-20 Test between adjacent contacts of mated and unmated connector assemblies.500 VAC for 1 minute.	The dielectric shall withstand 500VAC for 1 minute at sea level.

GENESIS TECH ELECTRONICS INC.

PRODUCT SPECIFICATION: 110-10008

GENESIS PN: 110-10008-01

Low level contact resistance(LLCR)	EIA 364-23 Subject mated contacts assembled in housing to 20mV Max. open circuit at 100mA Max. Test setup per Genesis Spec. – GTI-Q-SOP0019	Initial: 50m Ω maximum Resistance increase to 65m Ω maximum after stress
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3.8 MECHANICAL PERFORMANCE

Parameter	Procedure	Requirement
Insertion Force	EIA 364-13 Measure force necessary to mate connector assemblies at Max. rate of 12.5mm/min.	45N max
Removal Force	EIA 364-13 Measure force necessary to unmate connector assemblies at Max. rate of 12.5mm/min.	4N min
Durability	EIA 364-09 Mate and unmate connector assemblies for 50 cycles at Max. rate of 200 cycles per hour.	No physical damage. Meet requirements of additional tests as specified in the test sequence

3.9 ENVIRONMENTAL PERFORMANCE

Parameter	Procedure	Requirement
Physical shock	EIA 364-27 Subject mated connectors to 30 g's half-sine shock pulses of 11 msec duration. Three shocks in each direction applied along three mutually perpendicular planes for a total of 18 shocks.	No discontinuities of 1 μ s or longer duration. No physical damage.
Random vibration	EIA 364-28 Condition V Test letter A Subject mated connectors to 5.35 g's RMS. 30 minutes in each of three mutually perpendicular planes. (See NOTE 2) Test setup per Genesis Spec. – GTI-Q-SOP0020	No discontinuities of 1 μ s longer duration.
Humidity	EIA 364-31 Method III Test Condition A. Subject mated connectors to 96 hours at 40°C with 90% RH to 95% RH.	See NOTE 1.

GENESIS TECH ELECTRONICS INC.

PRODUCT SPECIFICATION: 110-10008
 GENESIS PN: 110-10008-01

Temperature life	EIA 364-17 Test Condition III Method A. Subject mated connectors to temperature life at +85°C for 500 hours.	See NOTE 1.
Thermal shock	EIA 364-32 Test Condition 1. Subject mated connectors to 10 cycles between -55°C and +85°C	See NOTE 1.
Salt Spray	Subject connector to salt solution concentration shall be 5% and air supply 35°C for 4 hours per EIA-364-26B.	1. No obvious cosmetic difference. 2. Contact Resistance: 65 milliohms maximum.
	Subject connector to salt solution concentration shall be 5% and air supply 35°C for 48 hours per EIA-364-26B.	1. Probably obvious cosmetic difference. 2. Contact Resistance: 65 milliohms maximum.
Solder-ability	EIA 364-52 At a temperature of 245+5°C for 5+0.5 seconds. Dip tails into flux for 5 second, drain, and then dip into the solder pot and keep for 5 seconds.	More than 95% of the Solder-able area shall be covered with solder
Resistance to Solder reflow Heat	1). Reflow part Max 260°C ± 5°C for 10sec. 2). Pre-heat part 130~180°C,60~120 sec *The number of times through reflow oven is 2 times Per EIA-364-56	Tested housing shall show no evidence of deformation and no physical damage.

Figure 2

NOTE -

1. Shall meet EIA 364-18 Visual Examination requirements, show no physical damage, and shall meet requirements of additional tests as specified in the test sequence.
2. Vibration test fixture is to be determined by each user with connector vendors.

4.0 PRODUCT QUALIFICATION AND REQUALIFICATION TEST SEQUENCE



Test Group 	A	B	C	D	E	F	
Test or examination 							
Examination of product	1,9	1,9	1,5	1,8	1,3	1,5	
Insulation resistance				2,6			
Dielectric withstanding voltage				3,7			
Low level contact resistance(LLCR)	2,8	3,7	2,4			2,4	
Insertion Force	3,6	2					
Removal Force	4,7	8					
Durability	5	4					
Physical shock		6					
Random vibration		5					
Humidity				5			
Temperature life			3				
Thermal shock				4			
Salt Spray						3	
Solder-ability					2		

Figure 3

5.0 PRODUCT PACKAGE DRAWINGS

- 5.1 Product to be supplied in tray as shown in product drawing unless otherwise specified.
- 5.2 Test packaging according to standard ISTA shipping specifications.

6.0 QUALITY ASSURANCE PROVISIONS

6.1 Test Conditions:

A. Sample Selection

Connector housings and contact shall be prepared in accordance with applicable instruction sheets and shall be selected from current production. All test groups shall each consist of a minimum of 5 connectors.

B. Test Sequence

Qualification inspection shall be verified by testing samples as specified in Figure 3.

GENESIS TECH ELECTRONICS INC.

PRODUCT SPECIFICATION: 110-10008
GENESIS PN: 110-10008-01

6.2 Requalification Testing:

If changes significantly affecting form, fit or function are made to product or manufacturing process, product assurance shall coordinate qualification testing, consisting of all or original testing sequence as determined by development/product, quality and reliability engineering.

6.3 Acceptance:

Acceptance is based on verification that product meets requirements of Figure 1. Failures attributed to equipment, test setup or operator deficiencies shall not disqualify. When a product failure occurs, corrective action shall be taken and samples resubmitted for qualification. Testing to confirm corrective action is required before submittal.